

**Notice of References Cited**

 Application/Control No.  
 10/648,594

 Applicant(s)/Patent Under  
 Reexamination  
 CHEN ET AL.

 Examiner  
 Anatoly Vortman

 Art Unit  
 2835

Page 1 of 2

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,780,101	07-1998	Nolan et al.	427/216
	B	US-6,473,351	10-2002	Tomanek et al.	365/215
	C	US-5,965,267	10-1999	Nolan et al.	428/408
	D	US-5,753,088	05-1998	Olk, Charles Howard	204/173
	E	US-5,742,471	04-1998	Barbee et al.	361/312
	F	US-5,698,175	12-1997	Hiura et al.	423/447.1
	G	US-5,641,466	06-1997	Ebbesen et al.	423/447.2
	H	US-5,344,676	09-1994	Kim et al.	427/468
	I	US-2004/0005736	01-2004	Searls et al.	438/122
	J	US-2004/0097635	05-2004	Fan et al.	524/496
	K	US-6,542,370	04-2003	Wang et al.	361/704
	L	US-6,131,651	10-2000	Richey, III, Joseph B.	165/185
	M	US-6,060,166	05-2000	Hoover et al.	428/408

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
 Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination CHEN ET AL.	
		Examiner Anatoly Vortman	Art Unit 2835	Page 2 of 2

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,052,280	04-2000	Dilley et al.	361/687
	B	US-5,898,569	04-1999	Bhatia, Rakesh	361/700
	C	US-5,566,752	10-1996	Arnold et al.	165/185
	D	US-5,390,734	02-1995	Voorhes et al.	165/185
	E	US-5,316,080	05-1994	Banks et al.	165/185
	F	US-5,077,637	12-1991	Martorana et al.	361/717
	G	US-2003/0111333	06-2003	Montgomery et al.	204/164
	H	US-6,278,231	08-2001	Iwasaki et al.	313/310
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.